

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

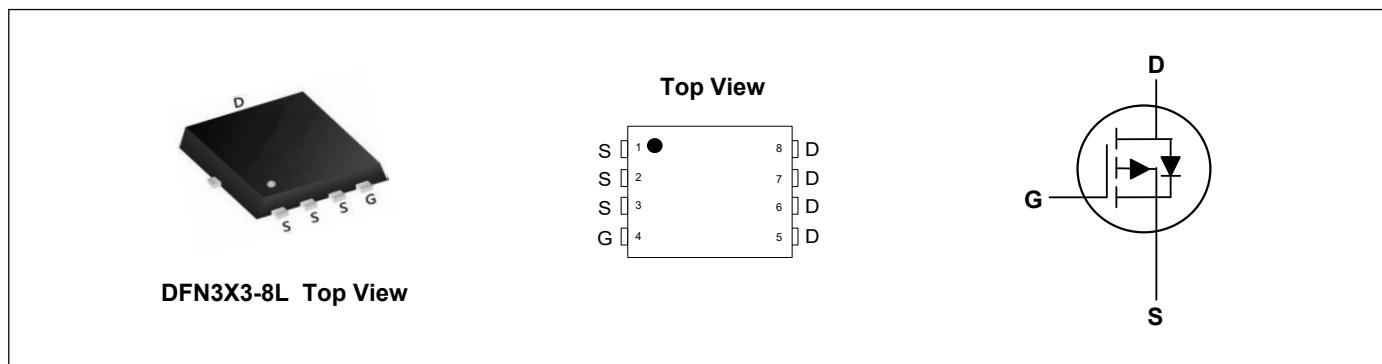
Product Summary



V_{DS}	-30	V
I_D	-42	A
$R_{DS(ON)}$ (at $V_{GS}=-10V$)	14	mΩ
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	22	mΩ

Applications

- High Frequency Point-of-Load, Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch, LED applications



Absolute Maximum Ratings($T_c=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Rating		Units
		10S	Steady State	
Drain-Source Voltage	V_{DS}		-30	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_c = 25^\circ\text{C}$		-42	A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_c = 100^\circ\text{C}$		-27	A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_A = 25^\circ\text{C}$	-14.3	-9	A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_A = 70^\circ\text{C}$	-11.4	-7.2	A
Pulsed Drain Current ²	I_{DM}		-130	A
Single Pulse Avalanche Energy ³	EAS		125	mJ
Avalanche Current	I_{AS}		-50	A
Total Power Dissipation ⁴	$P_D @ T_c = 25^\circ\text{C}$		37	W
Total Power Dissipation ⁴	$P_D @ T_A = 25^\circ\text{C}$	4.2	1.67	W
Storage Temperature Range	T_{STG}		-55 to 150	°C
Operating Junction Temperature Range	T_J		-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction-Ambient ¹ ($t \leq 10s$)	$R_{\theta JA}$	---	30	°C/W
Thermal Resistance Junction-Ambient ¹		---	75	°C/W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	---	3.36	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}$, $I_D=-250\mu\text{A}$	-30	---	---	V
BV_{DSS} Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_D=-1\text{mA}$	---	-0.023	---	$\text{V}/^\circ\text{C}$
Static Drain-Source On-Resistance ²	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=-10\text{V}$, $I_D=-30\text{A}$	---	---	14	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}$, $I_D=-15\text{A}$	---	---	22	$\text{m}\Omega$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}$, $I_D = -250\mu\text{A}$	-1.2	---	-2.5	V
$V_{\text{GS}(\text{th})}$ Temperature Coefficient	$\Delta V_{\text{GS}(\text{th})}$		---	4.6	---	$\text{mV}/^\circ\text{C}$
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=-24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	-1	μA
		$V_{\text{DS}}=-24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=55^\circ\text{C}$	---	---	-5	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
Forward Transconductance	g_{fs}	$V_{\text{DS}}=-5\text{V}$, $I_D=-30\text{A}$	---	30	---	S
Gate Resistance	R_g	$V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	9	---	Ω
Total Gate Charge (-4.5V)	Q_g	$V_{\text{DS}}=-15\text{V}$, $V_{\text{GS}}=-4.5\text{V}$, $I_D=-15\text{A}$	---	22	---	nC
Gate-Source Charge	Q_{gs}		---	8.7	---	
Gate-Drain Charge	Q_{gd}		---	7.2	---	
Turn-On Delay Time	$T_{\text{d}(\text{on})}$	$V_{\text{DD}}=-15\text{V}$, $V_{\text{GS}}=-10\text{V}$, $R_G=3.3\Omega$, $I_D=-15\text{A}$	---	8	---	ns
Rise Time	T_r		---	73.7	---	
Turn-Off Delay Time	$T_{\text{d}(\text{off})}$		---	61.8	---	
Fall Time	T_f		---	24.4	---	
Input Capacitance	C_{iss}	$V_{\text{DS}}=-15\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	2215	---	pF
Output Capacitance	C_{oss}		---	310	---	
Reverse Transfer Capacitance	C_{rss}		---	237	---	

Drain-Source Diode Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Continuous Source Current ^{1,5}	I_s	$V_G=V_D=0\text{V}$, Force Current	---	---	-42	A
Pulsed Source Current ^{2,5}	I_{SM}		---	---	-130	A
Diode Forward Voltage ²	V_{SD}	$V_{\text{GS}}=0\text{V}$, $I_s=-1\text{A}$, $T_J=25^\circ\text{C}$	---	---	-1	V
Reverse Recovery Time	t_{rr}	$I_F=-15\text{A}$, $di/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$	---	19	---	nS
	Q_{rr}		---	9	---	nC

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{\text{DD}}=-25\text{V}$, $V_{\text{GS}}=-10\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=-50\text{A}$
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

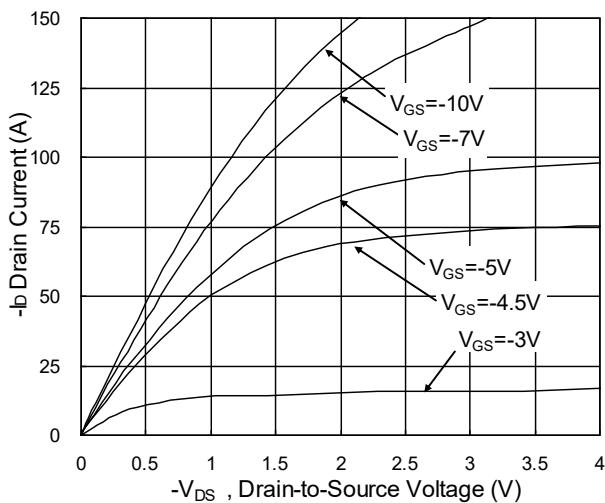


Fig.1 Typical Output Characteristics

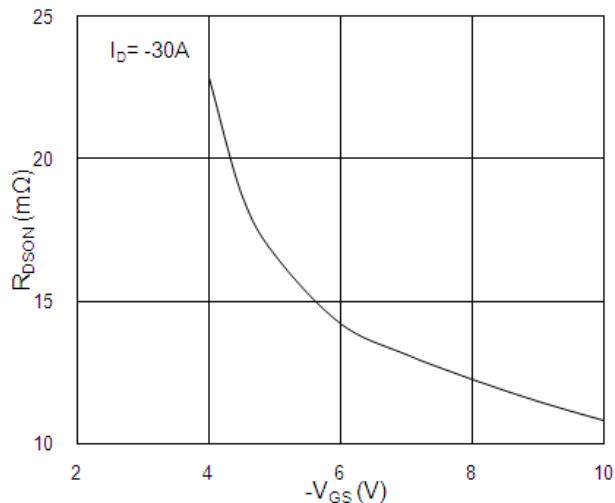


Fig.2 On-Resistance vs. G-S Voltage

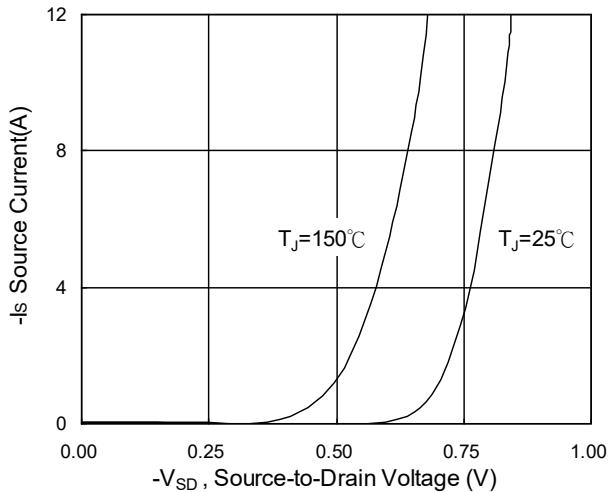


Fig.3 Forward Characteristics of Reverse

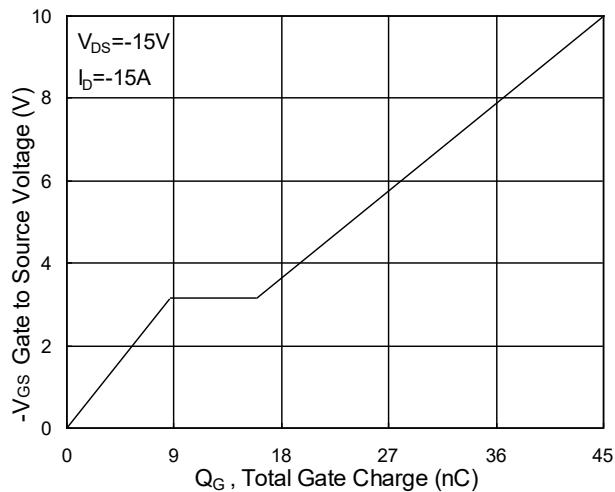


Fig.4 Gate-Charge Characteristics

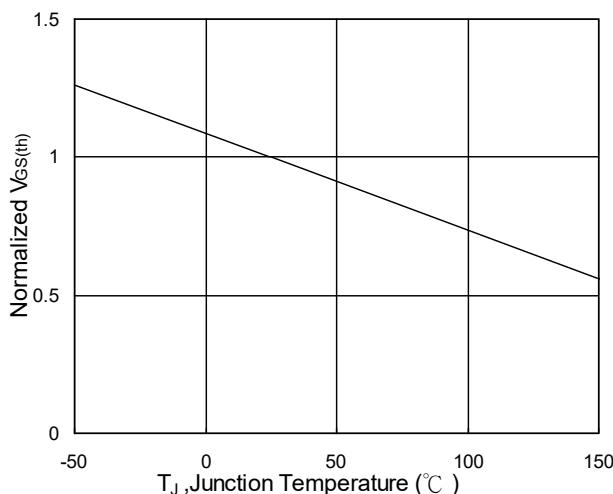


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

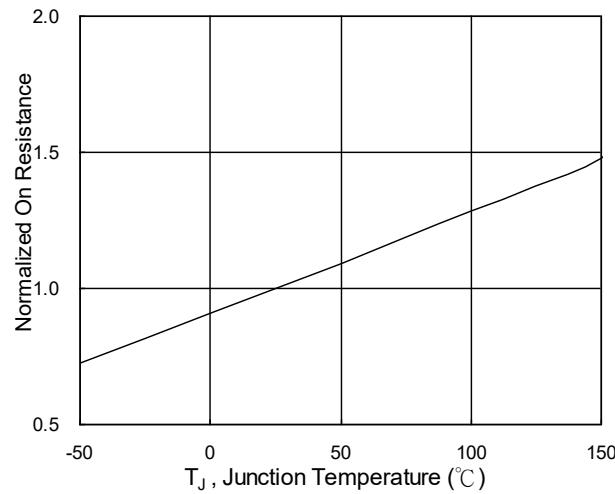
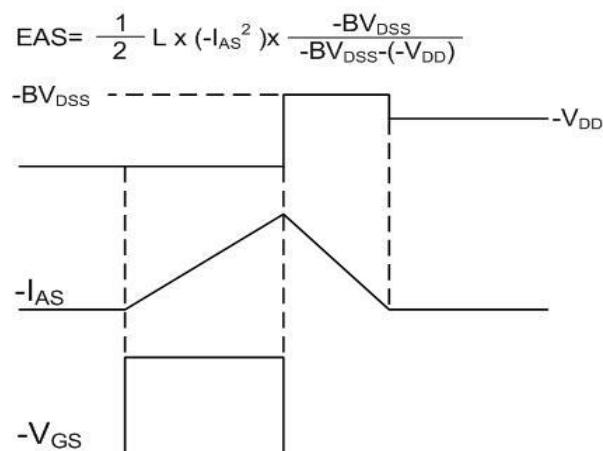
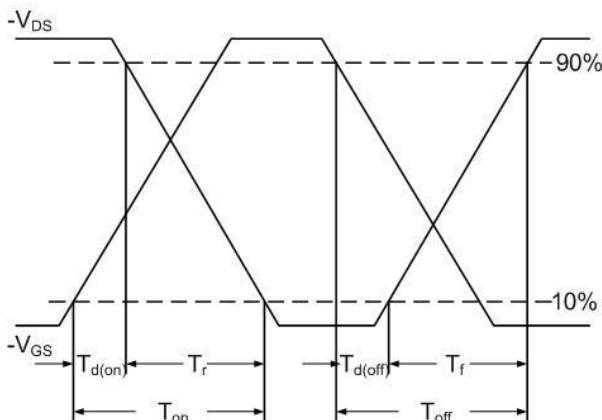
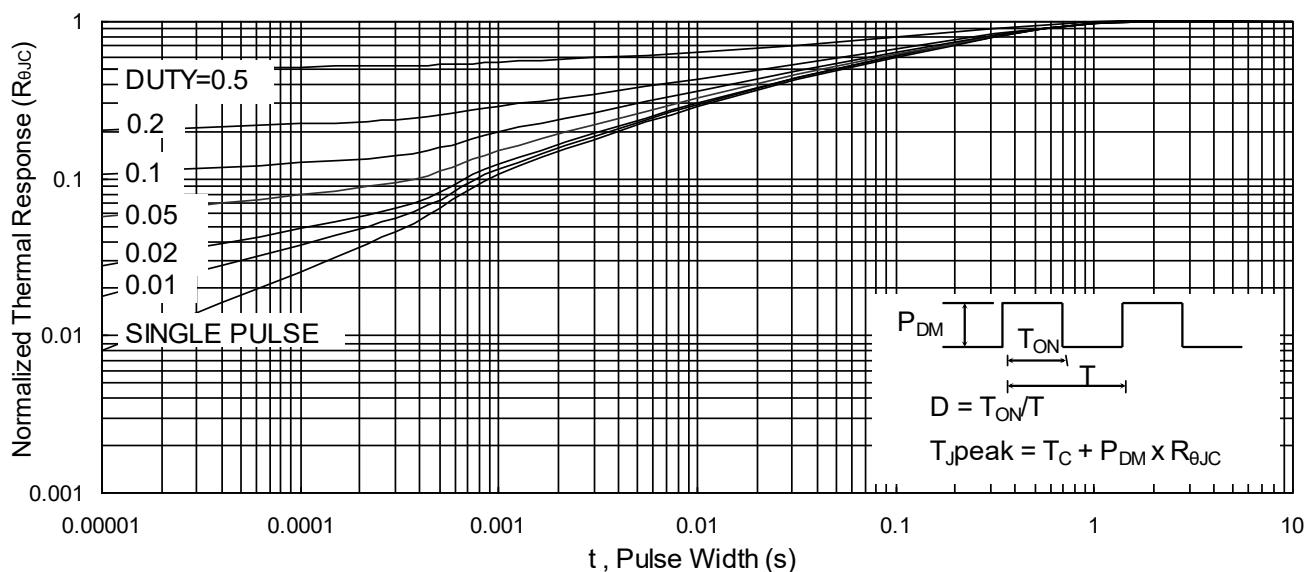
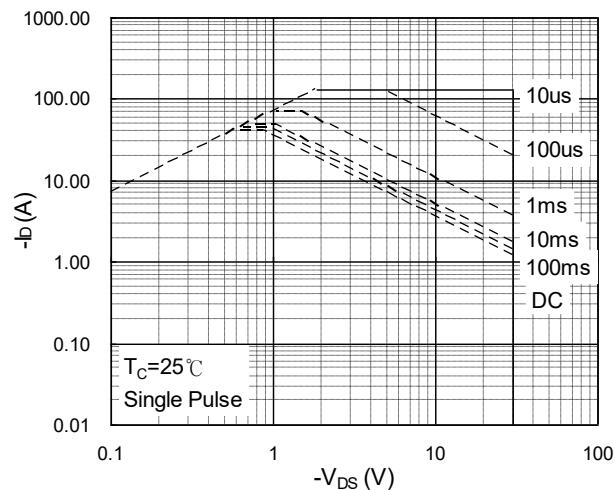
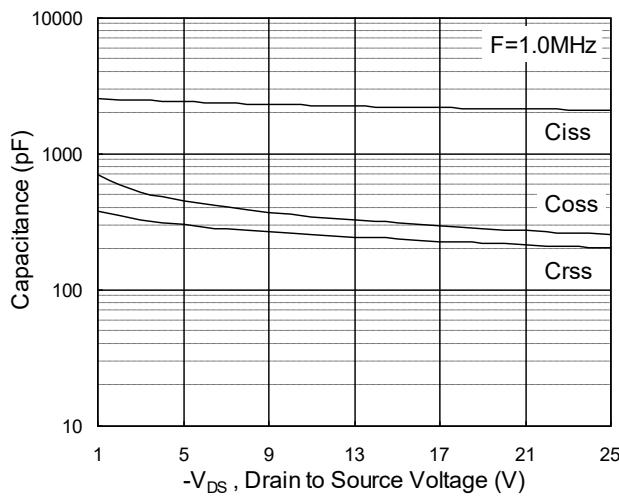
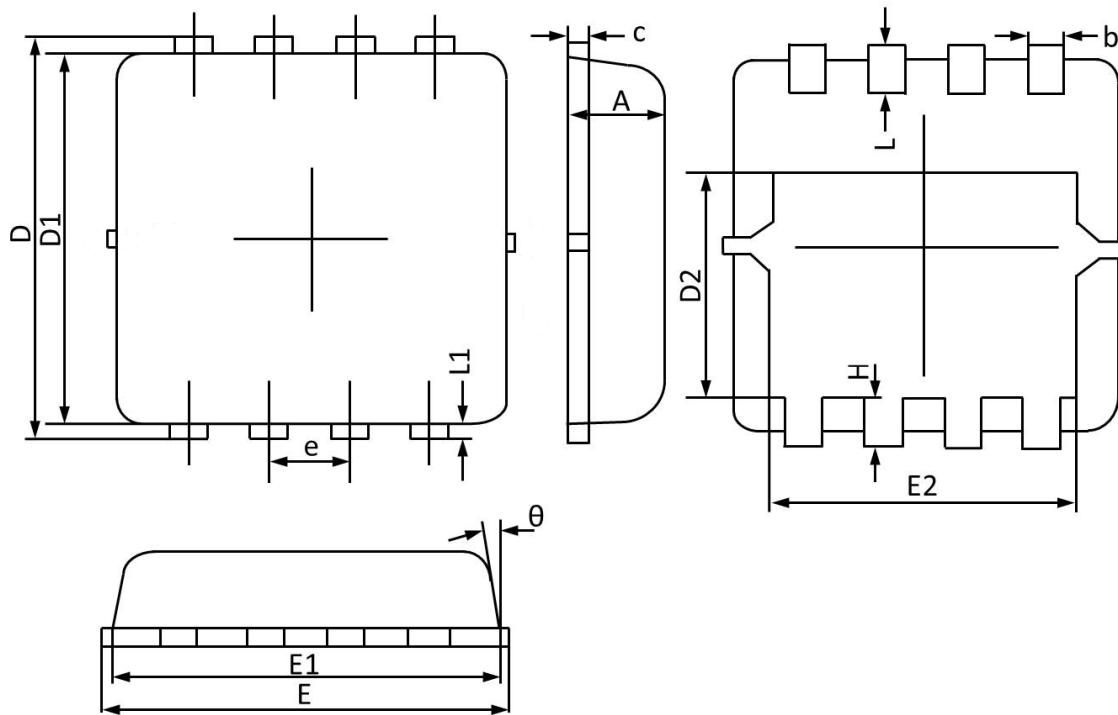


Fig.6 Normalized $R_{DS(on)}$ vs. T_J



DFN3X3-8L Package Outline Dimensions



Symbol	Dimensions (unit:mm)			Symbol	Dimensions (unit:mm)		
	Min	Typ	Max		Min	Typ	Max
A	0.70	0.75	0.85	E1	2.90	3.10	3.25
b	0.24	0.30	0.35	E2	2.35	2.50	2.60
c	0.10	0.17	0.25	e	0.65 BSC		
D	3.10	3.30	3.45	H	0.30	0.40	0.50
D1	2.90	3.05	3.20	L	0.30	0.40	0.50
D2	1.45	1.70	1.95	L1	--	0.13	--
E	3.05	3.25	3.40	θ	0°		14°